



NorSun



Optimized Ga-doped Cz wafers for POLO IBC solar cells with high efficiency and minimal LeTID degradation

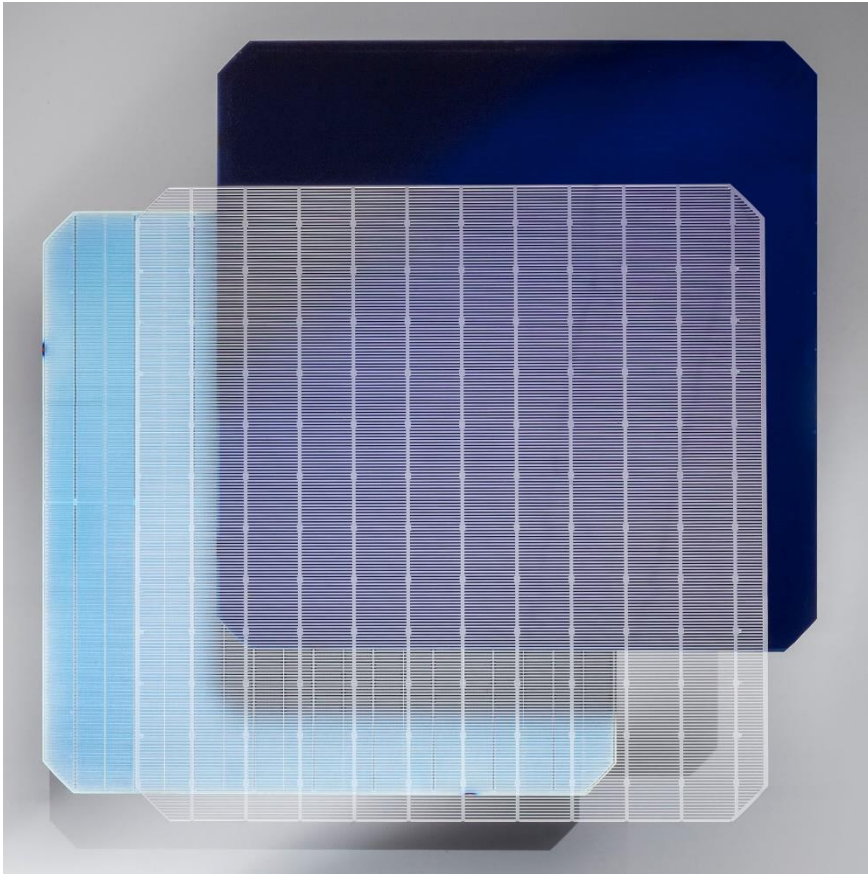
T. Dullweber¹, V. Mertens¹, M. Winter¹, S. Schimanke¹, M. Ripke¹, S. Dorn¹, Y. Larionova¹, G. Lange¹, K. Bothe¹, J. Schmidt^{1,2}, R. Brendel^{1,2}, A. K. Dahle³, Ö. Coskun⁴, N. Töre Sen⁴

¹Institute for Solar Energy Research Hamelin (ISFH), Germany

²Leibniz Universität Hannover, Germany

³NorSun AS, Norway

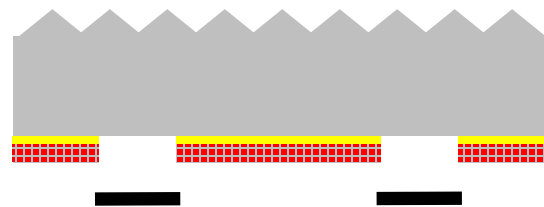
⁴Kalyon PV, Türkiye



POLO IBC process flow with shadow mask

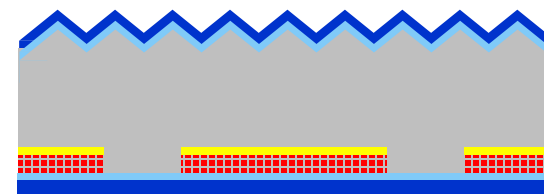


Texture &
rear polish

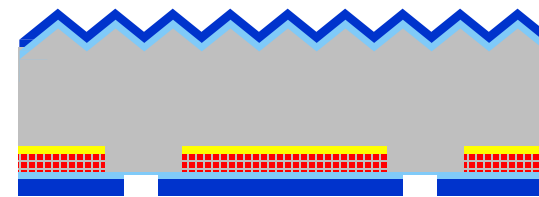


PECVD
 $\text{SiO}_x\text{N}_y/\text{n-a-Si}$
w/ shadow mask

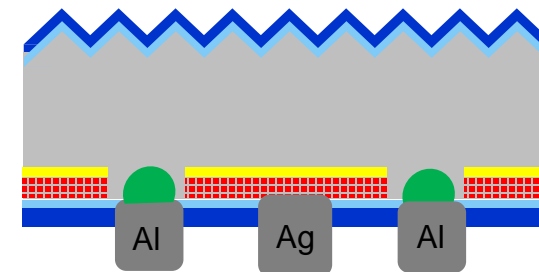
& Anneal



AlO_x/SiN
both sides



Laser contact opening



Ag and Al screen print
& firing

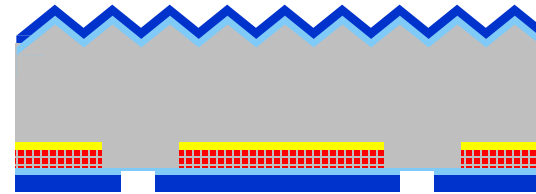
- Very lean POLO IBC process flow by ISFH^{1,2}

[1] T. Dullweber et al., 8th WCPEC (2022), p. 35 - 39
[2] V. Mertens et al., 40th EUPVSEC (2023), p. 020015

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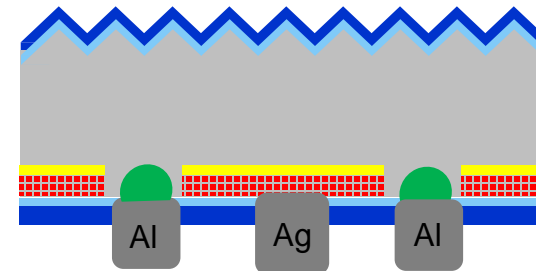
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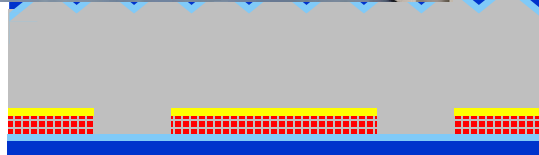
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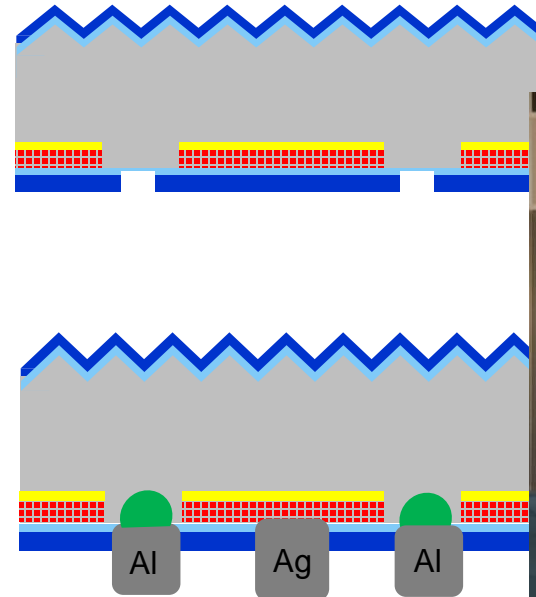
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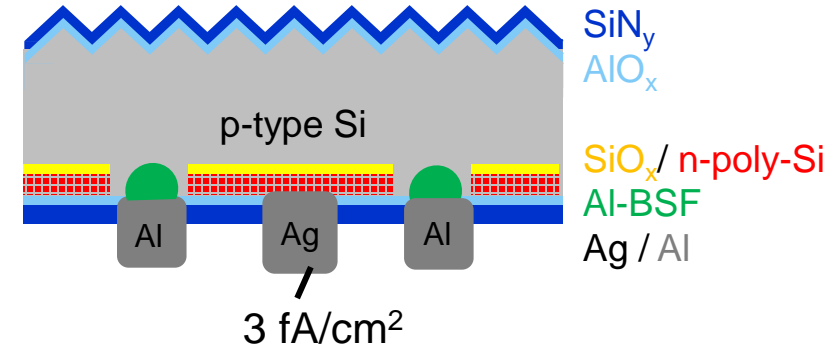
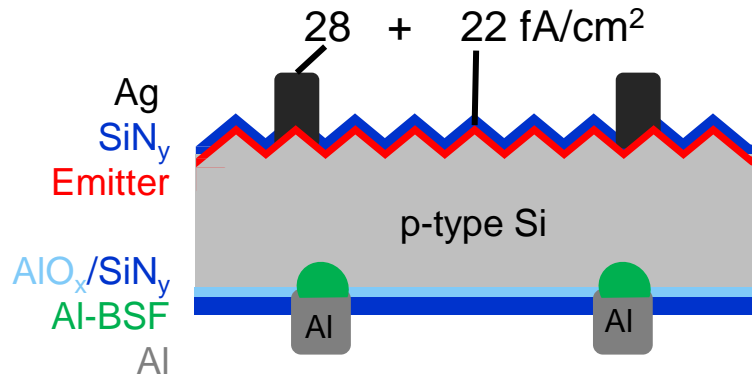
- Very lean POLO IBC process flow by ISFH^{1,2}
- Technology cooperation started with Kalyon PV

[1] T. Dullweber et al., 8th WCPEC (2022), p. 35 - 39
[2] V. Mertens et al., 40th EUPVSEC (2023), p. 020015

PERC+

vs.

POLO IBC



$$V_{oc} = 697 / 690 \text{ mV}$$

simulated / measured @ ISFH

$$\eta = 23.7 / 23.4\%$$

simulated / measured @ ISFH

$$733 / 716 \text{ mV}$$

simulated / measured @ ISFH

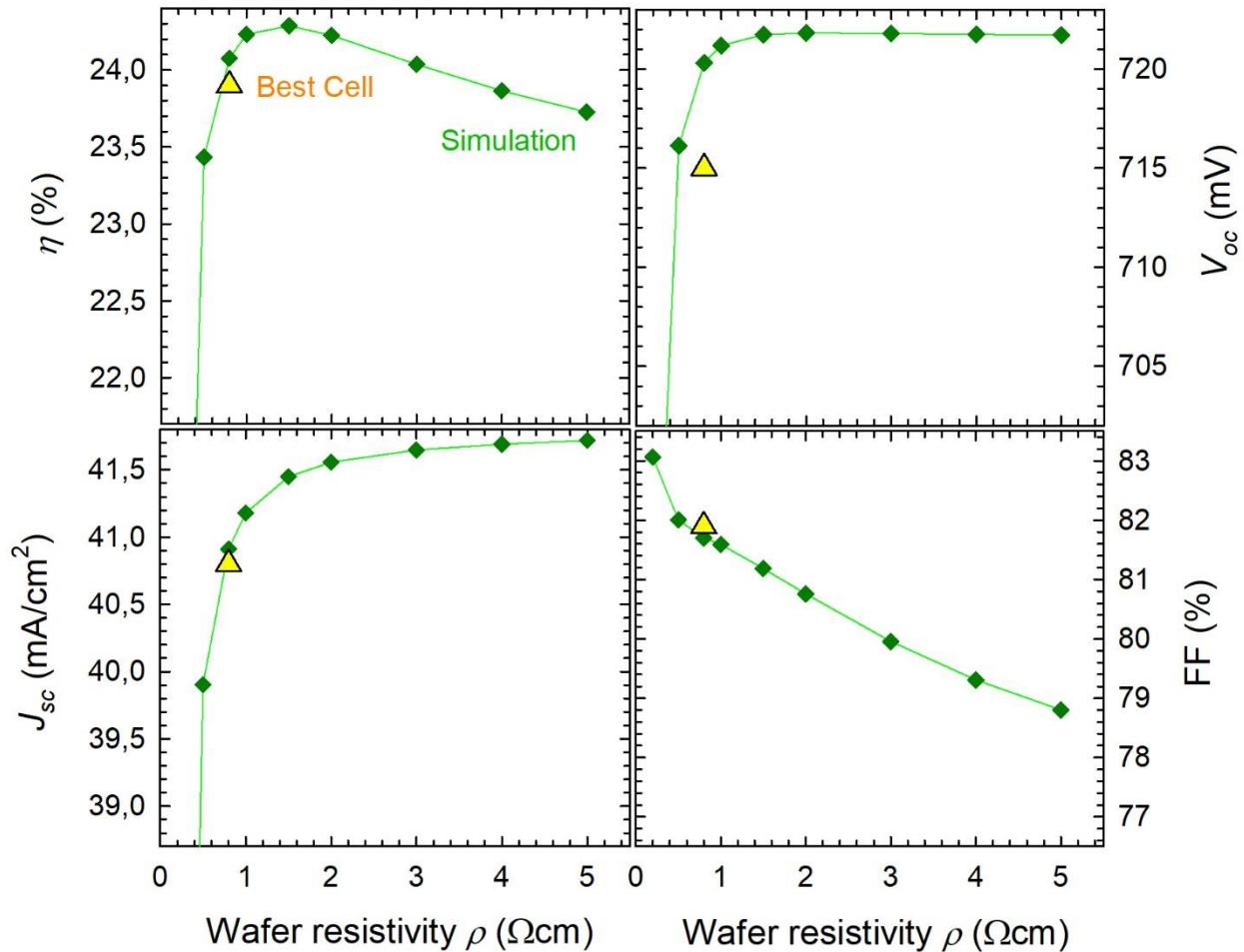
$$25.5 / 23.9\%$$

simulated / measured @ ISFH

Ga wafer resistivity $\rho = 0.4 - 0.8 \Omega \text{ cm}$

?

POLO IBC Quokka 3 simulations



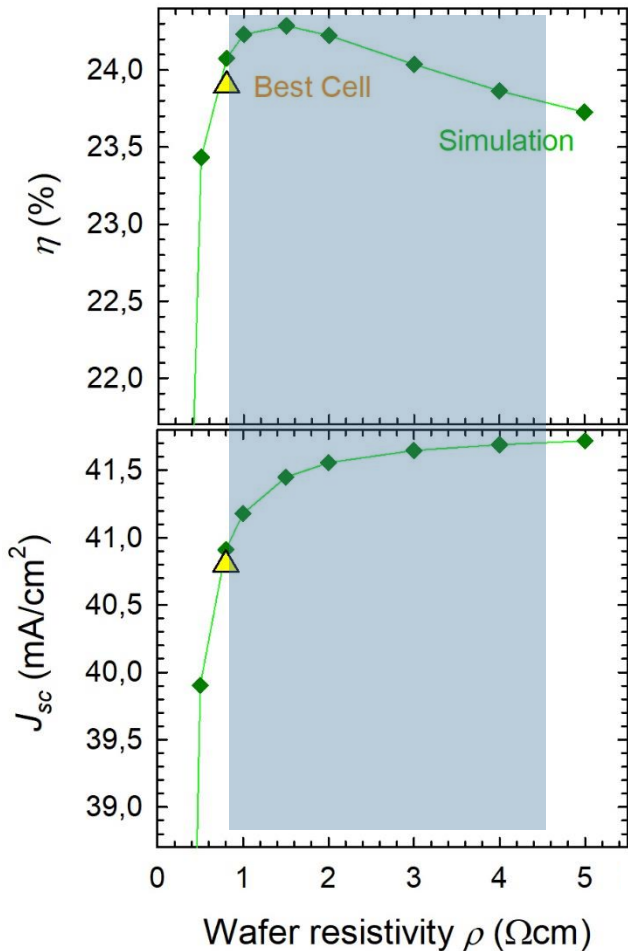
- Reference: 23.9% POLO IBC cell with 0.8 $\Omega\text{ cm}$ Ga wafer measured at ISFH
- Quokka 3:
 - POLO IBC input parameters from [1]
 - τ_{bulk} vs. ρ assumes B-doped wafers after regeneration^{2,3}
- Best POLO IBC efficiencies above 24% for wafer resistivity around 1.5 $\Omega\text{ cm}$

[1] V. Mertens et al., Sol. RRL 8 (2024) 23009196

[2] D. C. Walter et al., Progr. Photovolt. Res. Appl. 24 (2016)

[3] N. E. Grant et al., Sol. RRL 5 (2021) 2000754

POLO IBC Quokka 3 simulations



Cz Ingot at Kalyon PV

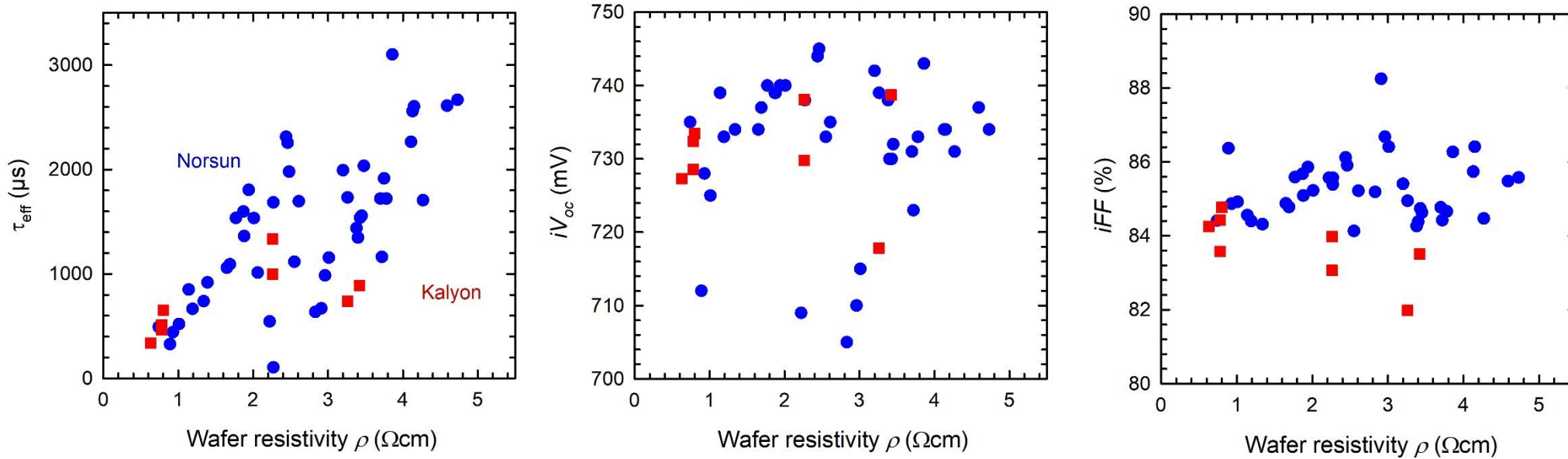
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- Best POLO IBC efficiencies above 24% for wafer resistivity around 1.5 Ωcm
- Norsun and Kalyon did grow Ga ingots with 0.7 – 4.8 Ωcm

[1] V. Mertens et al., Sol. RRL 8 (2024) 23009196]

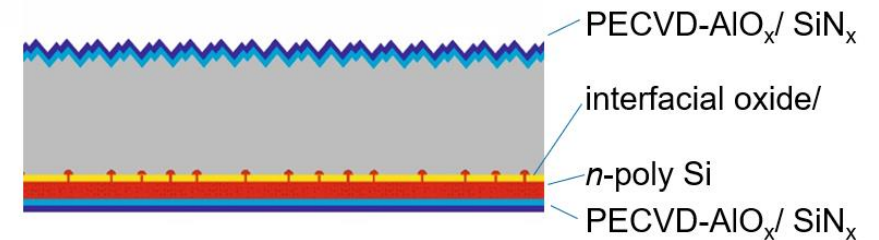
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POLO IBC lifetime precursors



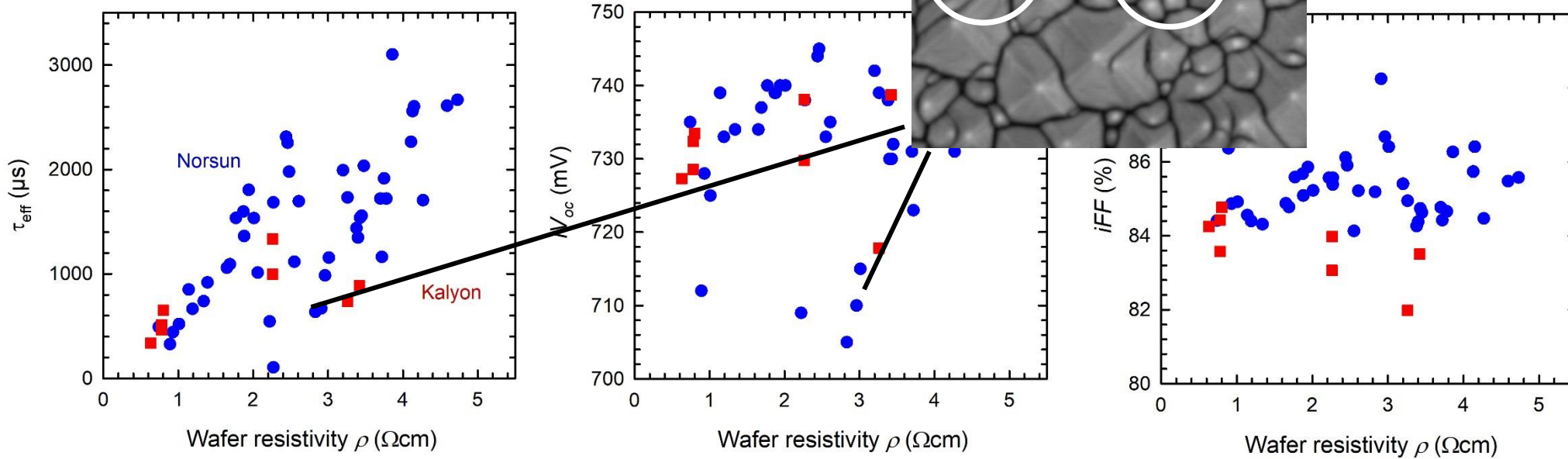
- τ_{eff} increases linearly with ρ up to 3.0 ms similar to [1]
- Implied efficiency $i\eta = iV_{oc} \times iFF \times J_{sc}$
 $= 740 \text{ mV} \times 86\% \times 42 \text{ mA/cm}^2$
 $= 26.7\%$



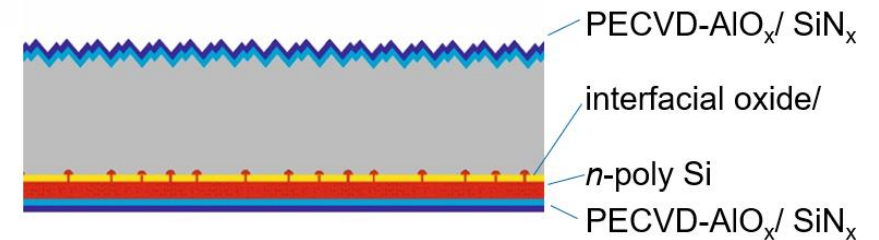
➔ Ga Cz wafers and industrial surface passivation support 25.5% POLO IBC potential

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POLO IBC lifetime precursors



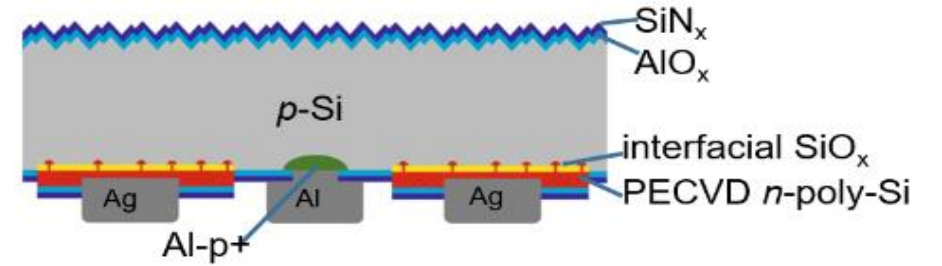
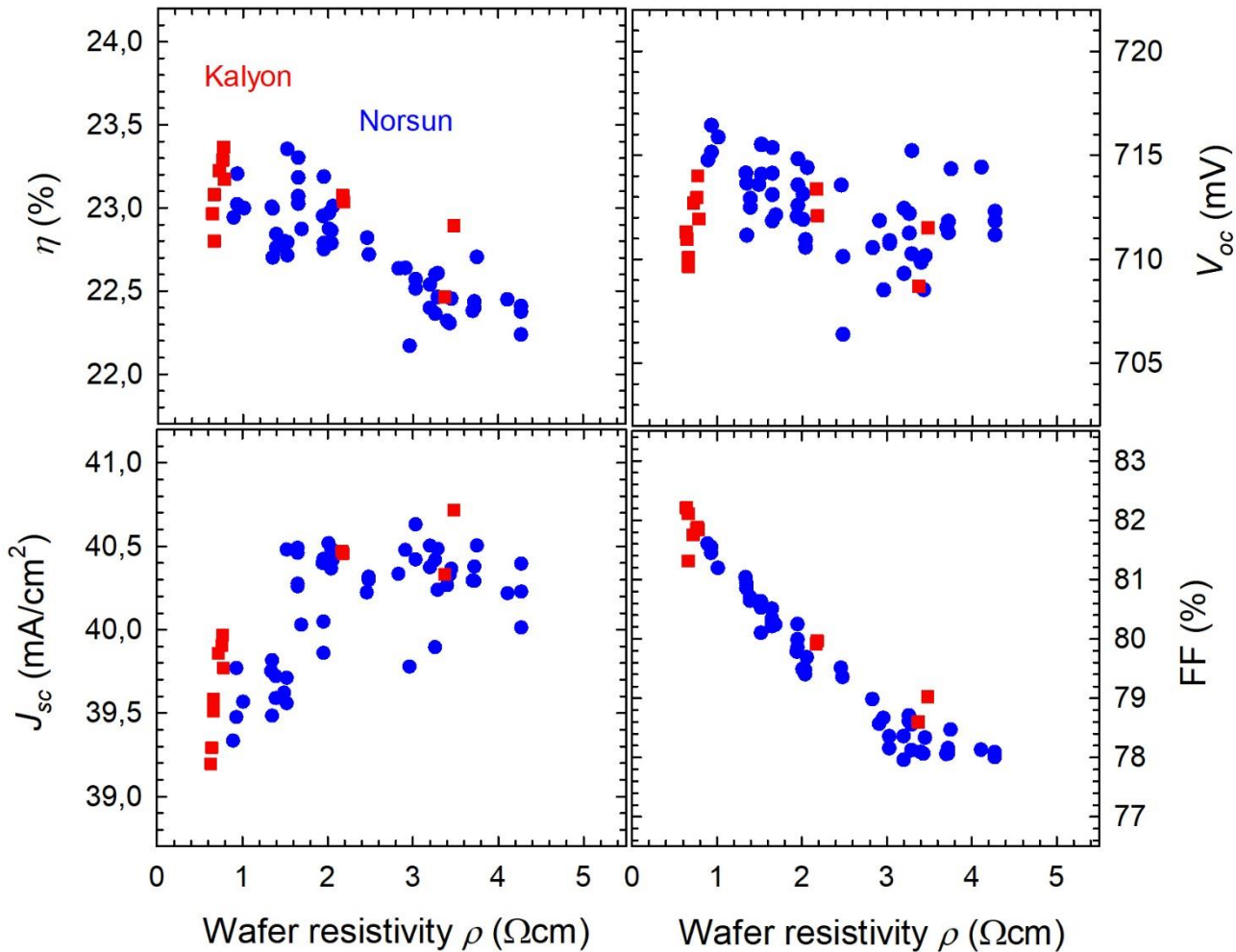
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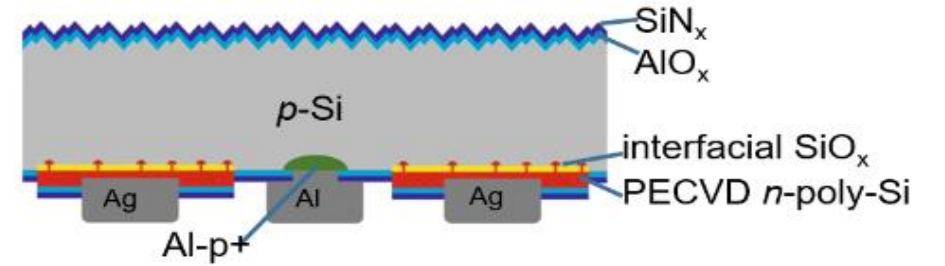
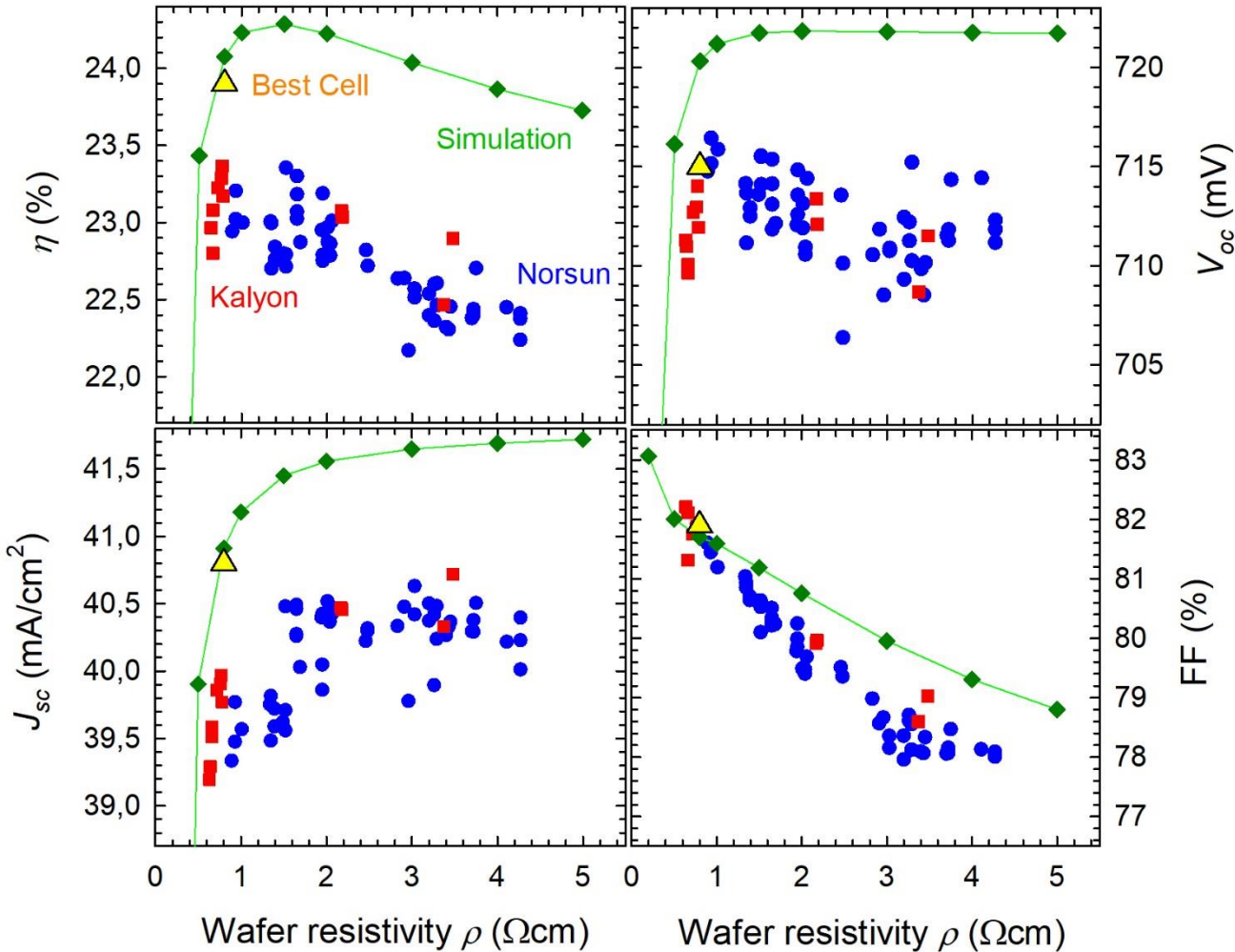
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POLO IBC solar cell results



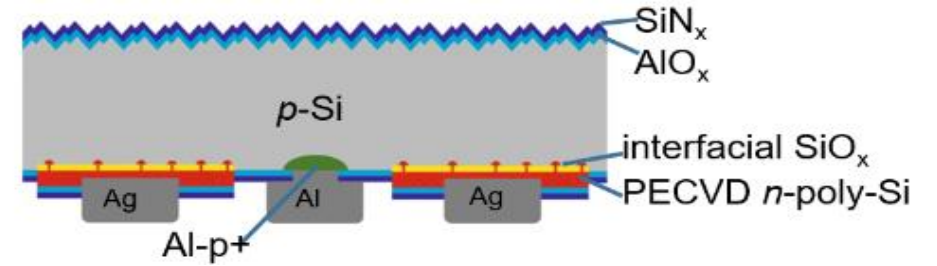
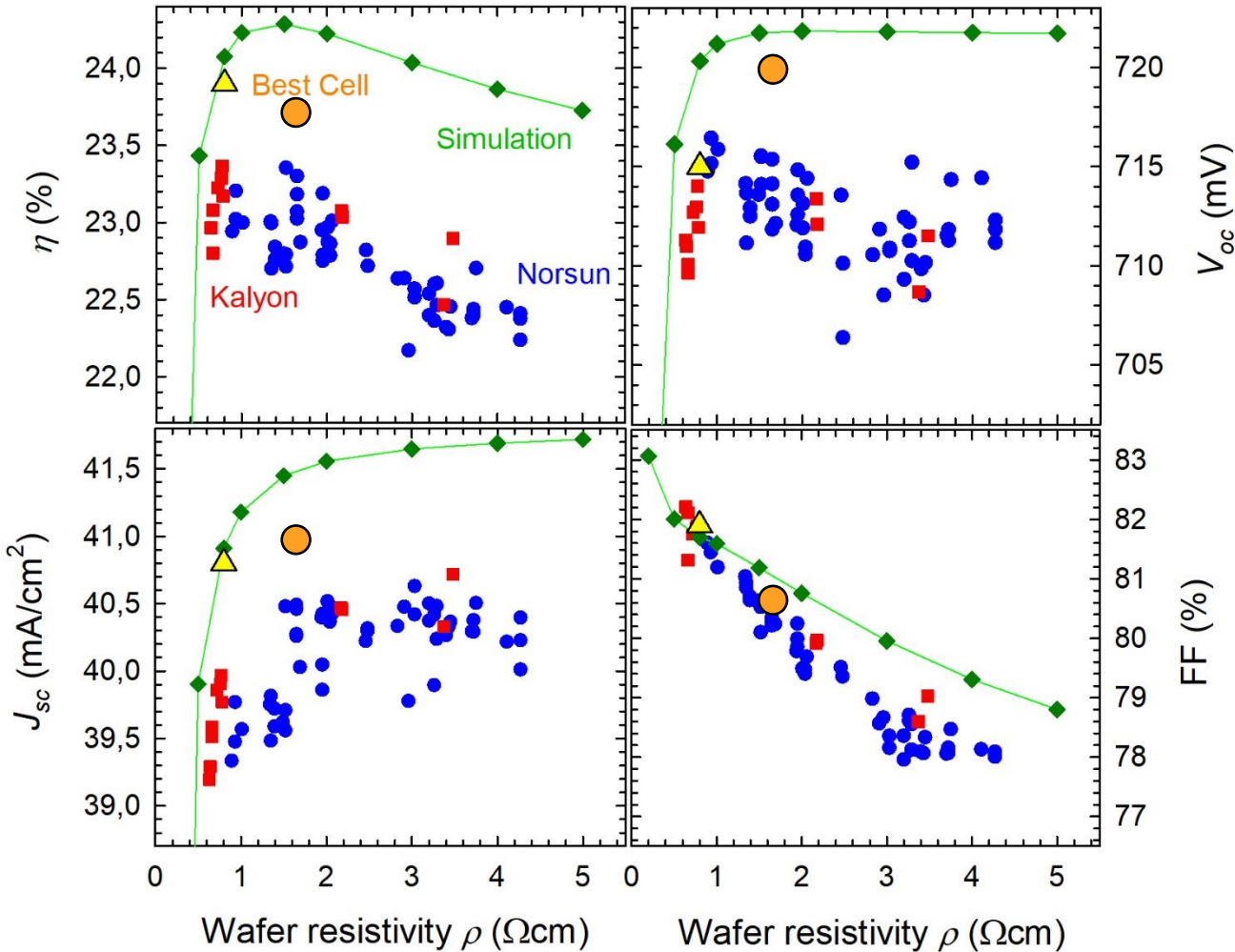
- With increasing Cz wafer resistivity
 - J_{sc} increases by $1 \text{ mA}/\text{cm}^2$
 - FF decreases by 5% abs.
- Best POLO IBC efficiencies of 23.4% for $1 \Omega \text{ cm} < \rho < 2 \Omega \text{ cm}$

POLO IBC solar cell results



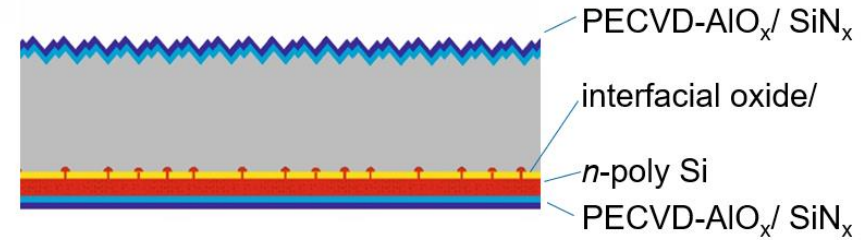
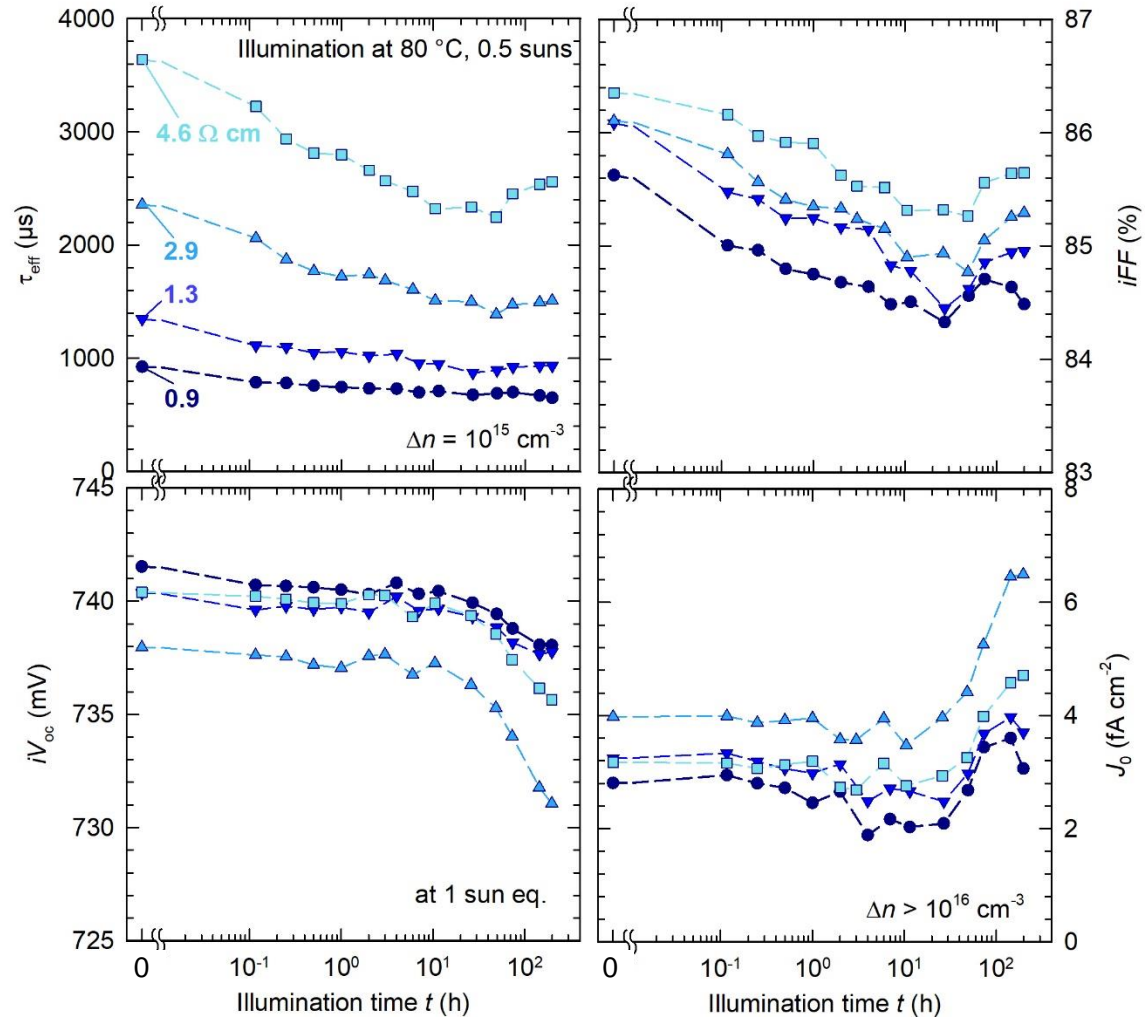
- J_{sc} and FF trends similar to Quokka 3 simulation
- Best POLO IBC efficiencies for $1 \Omega\text{cm} < \rho < 2 \Omega\text{cm}$
- η gap to best cell and simulations due to much lower J_{sc} . AlO_x/SiN blistering alloys Al „ghost“ contacts ?

POLO IBC solar cell results

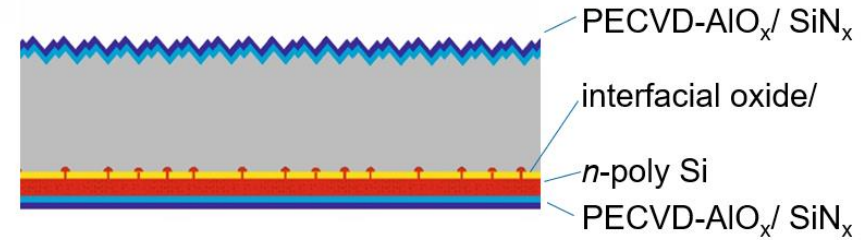
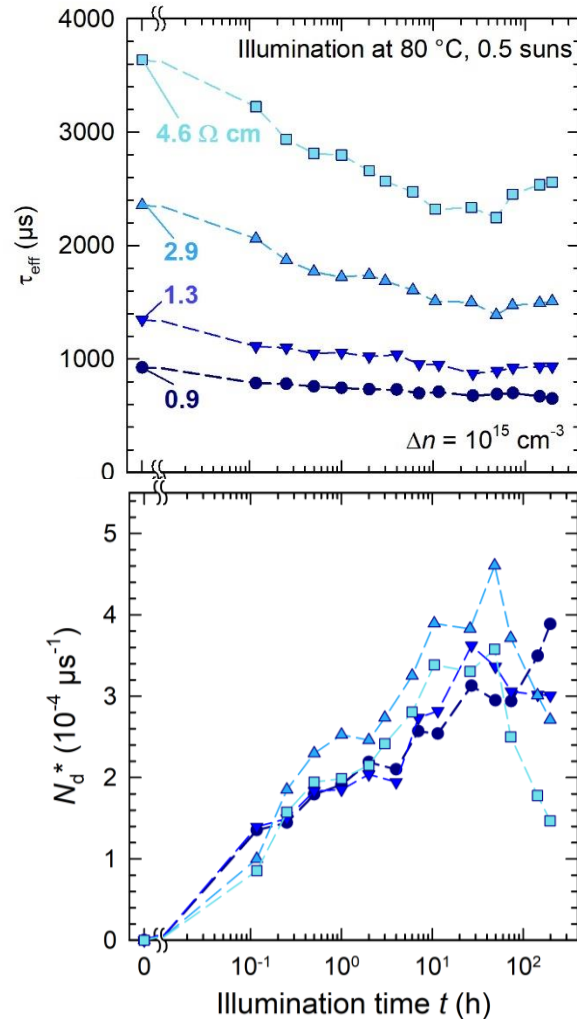


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LeTID at 80 °C, 0.5 suns with POLO IBC lifetime precursors



- LeTID slightly degrades τ_{bulk} and iFF
- iV_{oc} stable till 10 h
- $J_{0,surface}$ slightly increases due to degradation of surface passivation after 100 h

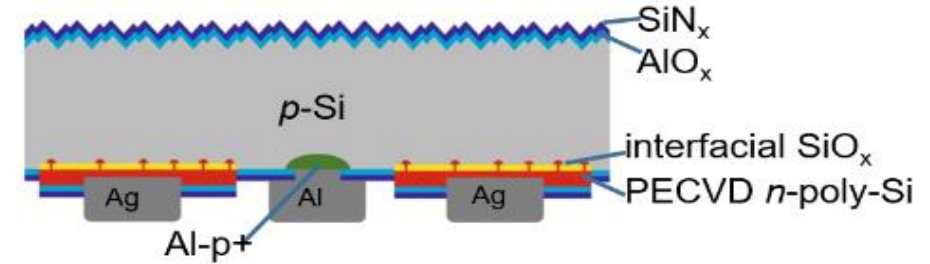
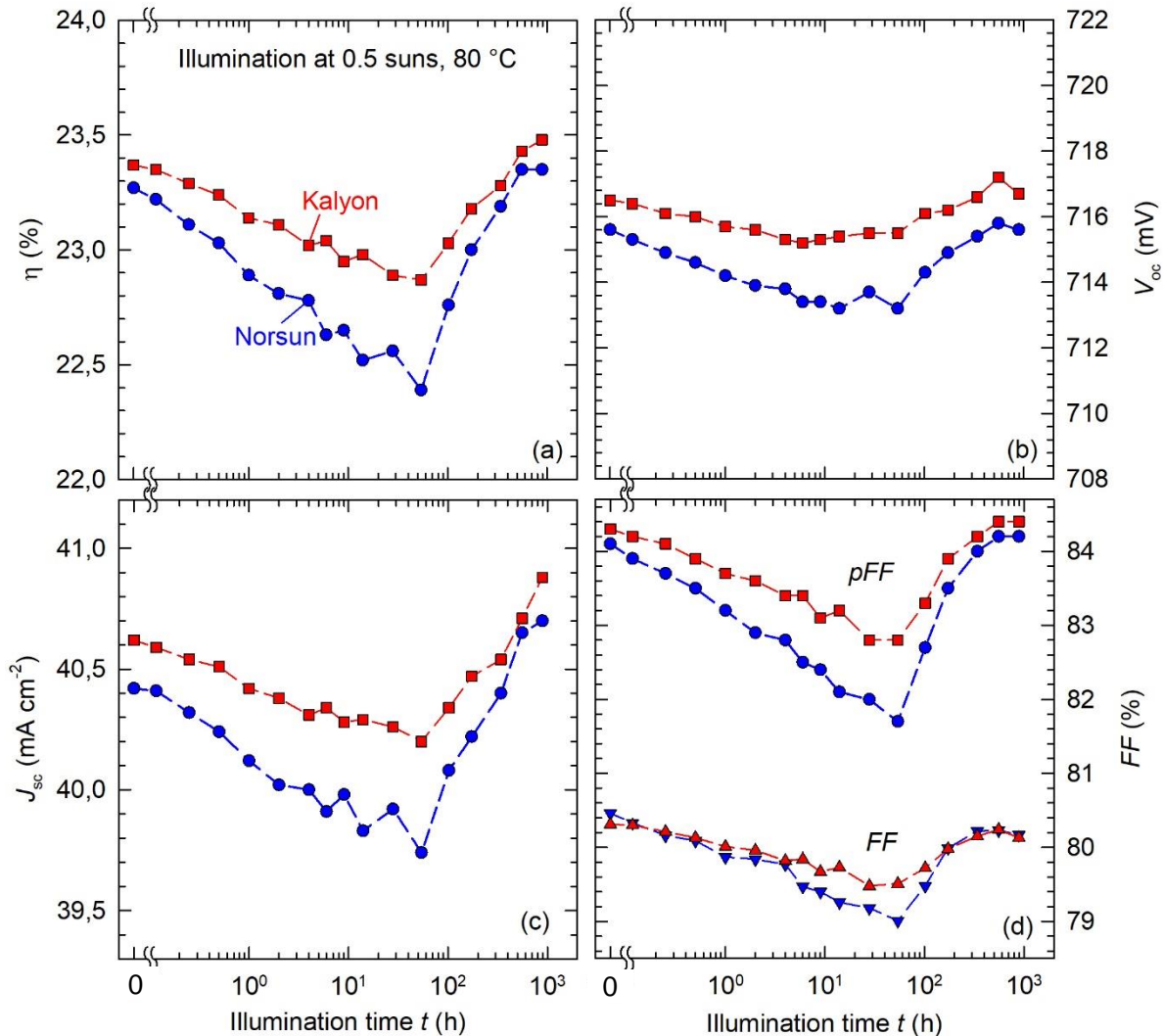


- Effective LeTID defect concentration calculated as

$$N_d^*(t) = \frac{1}{\tau_d(t)} - \frac{1}{\tau_0}$$

- N_d does not depend on Ga doping concentration
- Confirms hypothesis of recent publication¹ now with more statistics

LeTID at 80 °C and 0.5 suns of POLO IBC cells



- Maximum LeTID extent relatively small (<4% relative)
- LeTID affects mainly J_{sc} and pFF
- Full recovery of all IV parameters after 1000 h illumination
- LeTID norm test¹ n.a. to cells, no fail criteria
- LeTID could be further reduced by lower firing cool down rate^{2,3}

[1] Module test norm IEC TS 63342

[2] F. Maischner et al., SOLMAT 262 (2023) 112529

[3] M. Winter et al., IEEE JPV 13 (6), p. 849-857 (2023)

POLO IBC efficiency roadmap to 25%

23.9%: best POLO IBC cell

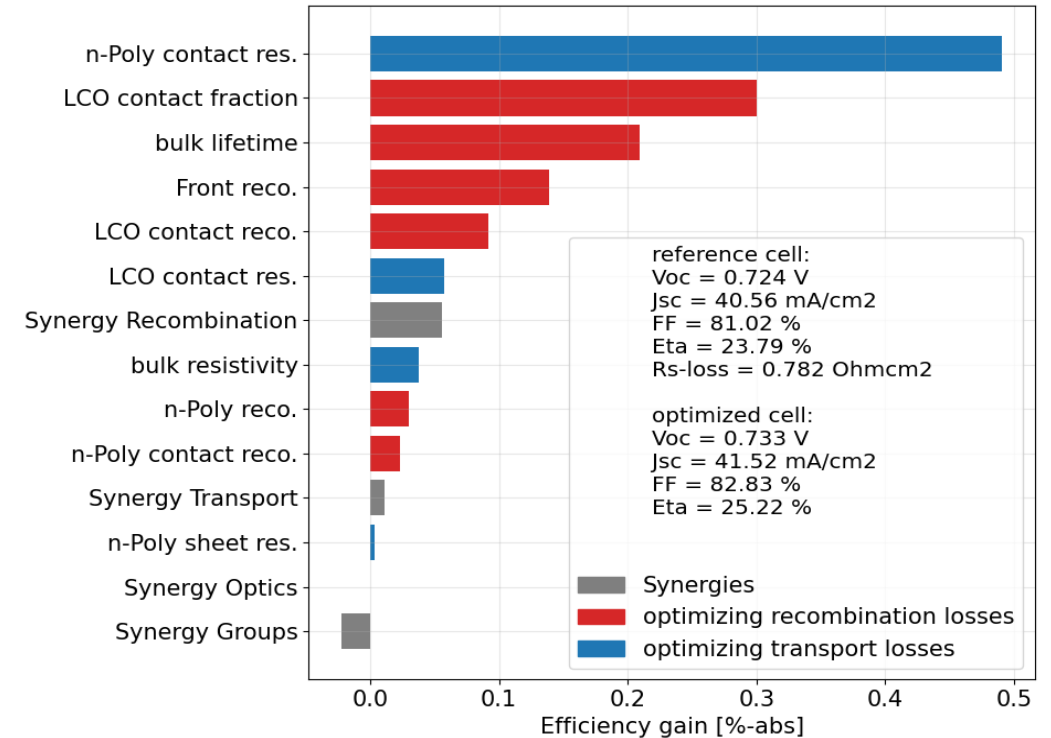
+ 0.5%: reducing Ag to n-poly Rc

+ 0.3%: reducing LCO area and $J_{0,Al-BSF}$

+ 0.3%: optimized BB and Pad design

+ 0.2%: 1.5 Ω cm Ga-doped Cz wafers

➔ 25.1% near-term efficiency potential

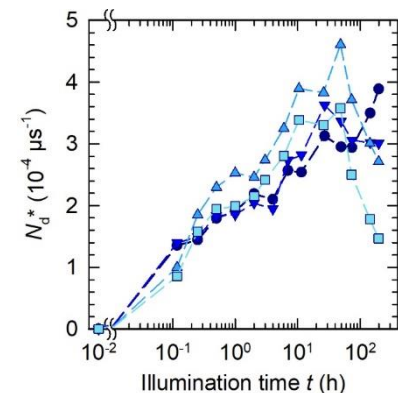
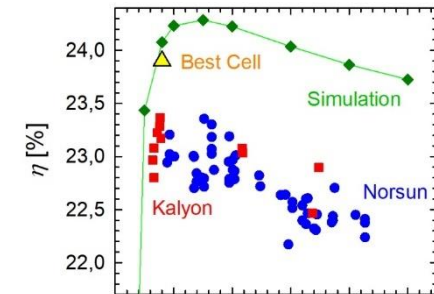
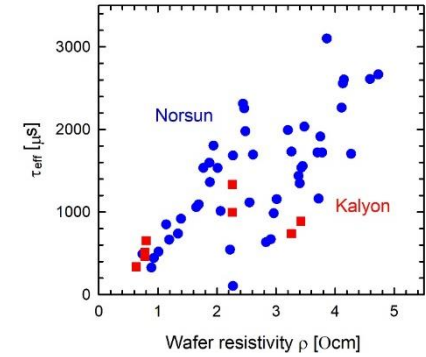


V. Mertens et al., Sol. RRL 8 (2024) 23009196

Summary



- τ_{eff} increases linearly with higher ρ up to 3.0 ms
- Calculated implied efficiency $i\eta = iV_{oc} \times iFF \times J_{sc} = 26.7\%$ for wide range of ρ
- Best POLO IBC efficiencies for $1.0 \text{ } \Omega\text{cm} < \rho < 2.0 \text{ } \Omega\text{cm}$
- Best POLO IBC cell with 23.9%. 0.5% η gap in this study due to lower J_{sc} .
AlO_x/SiN blistering alloys Al „ghost“ contacts ?
- 25% efficient POLO IBC cells targeted by optimizing Ag and Al metallization
- Maximum LeTID of POLO IBC cells < 4%rel.
- LeTID N_d does not depend on Ga doping concentration



Acknowledgements

- Funding was provided by the European Union of the IBC4EU project, the German Federal Ministry for Economic Affairs and Climate Action of the Olivia project, and by the State of Lower Saxony.
- **Thank you for your attention !**



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by the German Bundestag

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Germany

